Application/Control No. Applicant(s)/Patent Under Reexamination 10/829,670 WATANABE, TAKAYUKI Notice of References Cited Examiner Art Unit Page 1 of 1 3661 Yonel Beaulieu **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,615,134 09-2003 701/209 Ando, Kazutaka Α 370/347 US-5,260,944 11-1993 Tomabechi, Akitaka В 370/314 US-5,396,496 03-1995 Ito et al. С US-D US-Ε US-F US-G US-Н USı J US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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